

# CEP61A3/CEB61A3

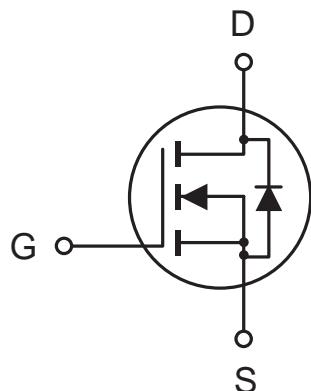
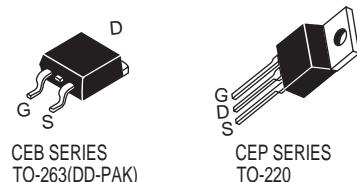
Jan. 2003

## N-Channel Logic Level Enhancement Mode Field Effect Transistor

4

### FEATURES

- 30V , 60A ,  $R_{DS(ON)}=12m\Omega$  @ $V_{GS}=10V$ .  
 $R_{DS(ON)}=19m\Omega$  @ $V_{GS}=4.5V$ .
- Super high dense cell design for extremely low  $R_{DS(ON)}$ .
- High power and current handling capability.
- TO-220 & TO-263 package.



### ABSOLUTE MAXIMUM RATINGS (Tc=25°C unless otherwise noted)

| Parameter   | Symbol   | Limit      | Unit  |
|---|----------|------------|-------|
| Drain-Source Voltage                                    | VDS      | 30         | V     |
| Gate-Source Voltage                                     | VGS      | $\pm 20$   | V     |
| Drain Current-Continuous<br>-Pulsed                     | ID       | 60         | A     |
|   | IDM      | 180        | A     |
| Drain-Source Diode Forward Current                      | IS       | 60         | A     |
| Maximum Power Dissipation @Tc=25°C<br>Derate above 25°C | PD       | 75         | W     |
|   |          | 0.5        | W/ °C |
| Operating and Storage Temperature Range                 | TJ, TSTG | -65 to 175 | °C    |

### THERMAL CHARACTERISTICS

|   |                 |      |      |
|---|-----------------|------|------|
| Thermal Resistance, Junction-to-Case    | $R_{\theta JC}$ | 2    | °C/W |
| Thermal Resistance, Junction-to-Ambient | $R_{\theta JA}$ | 62.5 | °C/W |

# CEP61A3/CEB61A3

4

## ELECTRICAL CHARACTERISTICS ( $T_c=25^\circ\text{C}$ unless otherwise noted)

| Parameter                                    | Symbol                   | Condition  | Min | Typ <sup>c</sup> | Max       | Unit             |
|--|--------------------------|--|-----|------------------|-----------|------------------|
| <b>OFF CHARACTERISTICS</b>                   |                          |  |     |                  |           |                  |
| Drain-Source Breakdown Voltage               | $\text{BV}_{\text{DSS}}$ | $V_{\text{GS}} = 0\text{V}, I_{\text{D}} = 250\mu\text{A}$   | 30  |                  |           | V                |
| Zero Gate Voltage Drain Current              | $I_{\text{DSS}}$         | $V_{\text{DS}} = 30\text{V}, V_{\text{GS}} = 0\text{V}$  |     | 1                |           | $\mu\text{A}$    |
| Gate-Body Leakage                            | $I_{\text{GSS}}$         | $V_{\text{GS}} = \pm 20\text{V}, V_{\text{DS}} = 0\text{V}$  |     |                  | $\pm 100$ | nA               |
| <b>ON CHARACTERISTICS<sup>a</sup></b>        |                          |  |     |                  |           |                  |
| Gate Threshold Voltage                       | $V_{\text{GS(th)}}$      | $V_{\text{DS}} = V_{\text{GS}}, I_{\text{D}} = 250\mu\text{A}$   | 1   |                  | 3         | V                |
| Drain-Source On-State Resistance             | $R_{\text{DS(ON)}}$      | $V_{\text{GS}} = 10\text{V}, I_{\text{D}} = 26\text{A}$  |     | 10               | 12        | $\text{m}\Omega$ |
|  |                          | $V_{\text{GS}} = 4.5\text{V}, I_{\text{D}} = 21\text{A}$   |     | 15               | 19        | $\text{m}\Omega$ |
| On-State Drain Current                       | $I_{\text{D(ON)}}$       | $V_{\text{DS}} = 10\text{V}, V_{\text{GS}} = 10\text{V}$   | 60  |                  |           | A                |
| Forward Transconductance                     | $g_{\text{FS}}$          | $V_{\text{DS}} = 10\text{V}, I_{\text{D}} = 26\text{A}$  |     | 34               |           | S                |
| <b>DYNAMIC CHARACTERISTICS<sup>b</sup></b>   |                          |  |     |                  |           |                  |
| Input Capacitance                            | $C_{\text{iss}}$         | $V_{\text{DS}} = 15\text{V}, V_{\text{GS}} = 0\text{V}$<br>$f = 1.0\text{MHz}$   |     | 1200             |           | pF               |
| Output Capacitance                           | $C_{\text{oss}}$         |  |     | 480              |           | pF               |
| Reverse Transfer Capacitance                 | $C_{\text{rss}}$         |  |     | 130              |           | pF               |
| <b>SWITCHING CHARACTERISTICS<sup>b</sup></b> |                          |  |     |                  |           |                  |
| Turn-On Delay Time                           | $t_{\text{D(ON)}}$       | $V_{\text{DD}} = 15\text{V},$<br>$I_{\text{D}} = 48\text{A},$<br>$V_{\text{GS}} = 10\text{V}$<br>$R_{\text{GEN}} = 24\Omega$ |     | 16               | 30        | ns               |
| Rise Time                                    | $t_{\text{r}}$           |  |     | 28               | 50        | ns               |
| Turn-Off Delay Time                          | $t_{\text{D(OFF)}}$      |  |     | 40               | 90        | ns               |
| Fall Time                                    | $t_{\text{f}}$           |  |     | 73               | 130       | ns               |
| Total Gate Charge                            | $Q_{\text{g}}$           | $V_{\text{DS}} = 15\text{V}, I_{\text{D}} = 48\text{A}$<br>$V_{\text{GS}} = 5\text{V}$                                       |     | 19               | 23        | nC               |
| Gate-Source Charge                           | $Q_{\text{gs}}$          |  |     | 5                |           | nC               |
| Gate-Drain Charge                            | $Q_{\text{gd}}$          |  |     | 9                |           | nC               |

# CEP61A3/CEB61A3

## ELECTRICAL CHARACTERISTICS ( $T_c=25^\circ\text{C}$ unless otherwise noted)

4

| Parameter  | Symbol   | Condition                                 | Min | Typ | Max | Unit |
|--|----------|---|-----|-----|-----|------|
| <b>DRAIN-SOURCE DIODE CHARACTERISTICS <sup>a</sup></b> |          |   |     |     |     |      |
| Diode Forward Voltage                                  | $V_{SD}$ | $V_{GS} = 0\text{V}$ , $I_S = 26\text{A}$ |     | 0.9 | 1.3 | V    |

### Notes

- a. Pulse Test: Pulse Width  $\leq 300 \mu\text{s}$ , Duty Cycle  $\leq 2\%$ .
- b. Guaranteed by design, not subject to production testing.

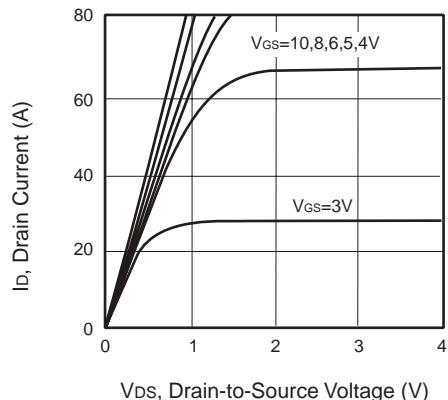


Figure 1. Output Characteristics

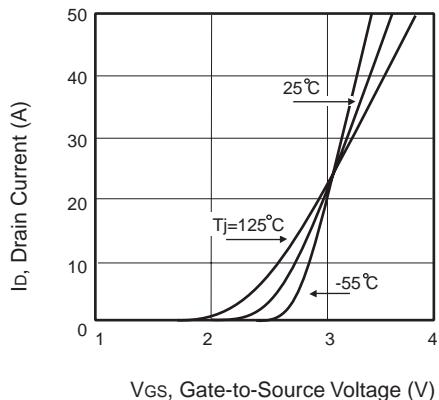


Figure 2. Transfer Characteristics

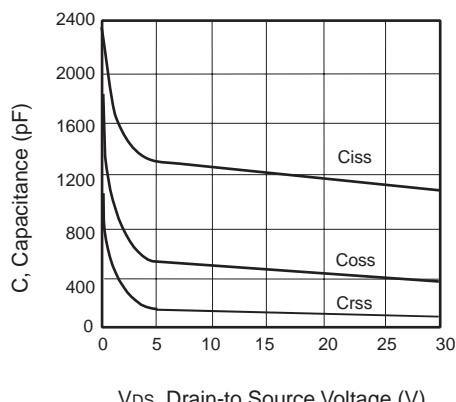


Figure 3. Capacitance

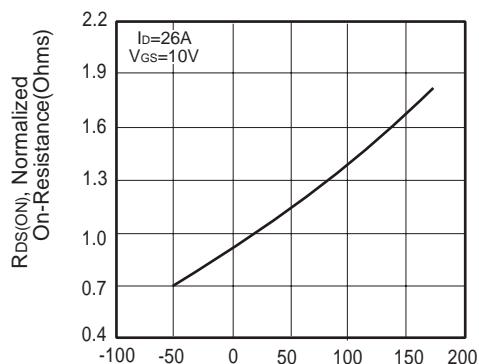
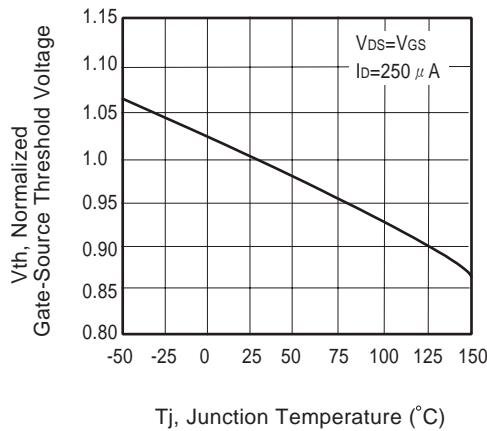


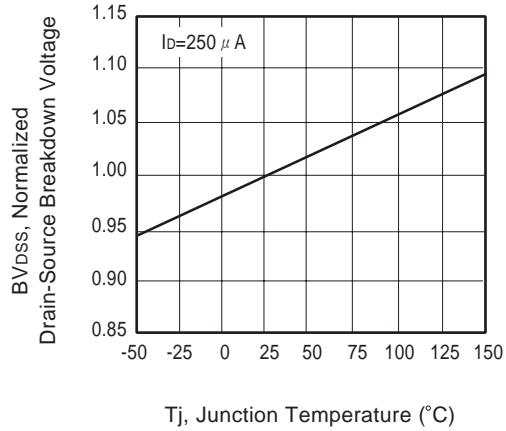
Figure 4. On-Resistance Variation with Temperature

# CEP61A3/CEB61A3

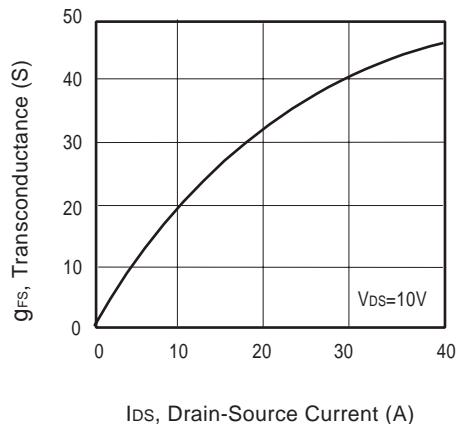
4



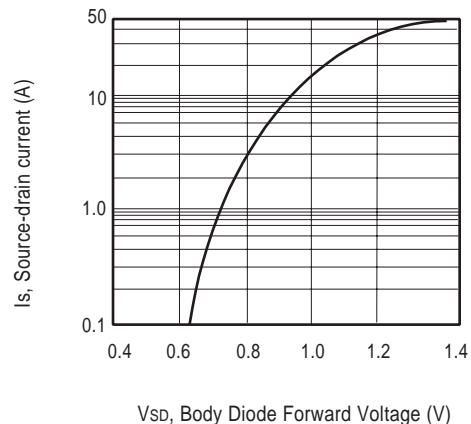
**Figure 5. Gate Threshold Variation with Temperature**



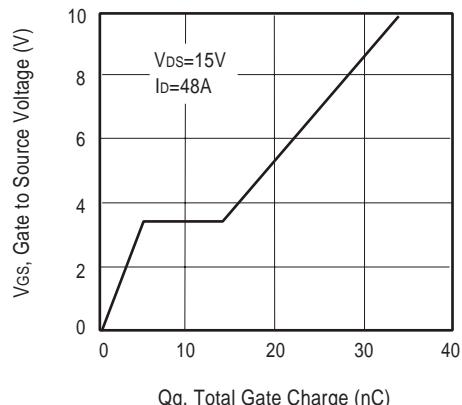
**Figure 6. Breakdown Voltage Variation with Temperature**



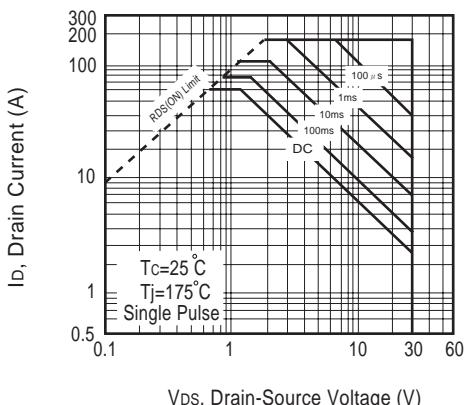
**Figure 7. Transconductance Variation with Drain Current**



**Figure 8. Body Diode Forward Voltage Variation with Source Current**



**Figure 9. Gate Charge**



**Figure 10. Maximum Safe Operating Area**

# CEP61A3/CEB61A3

4

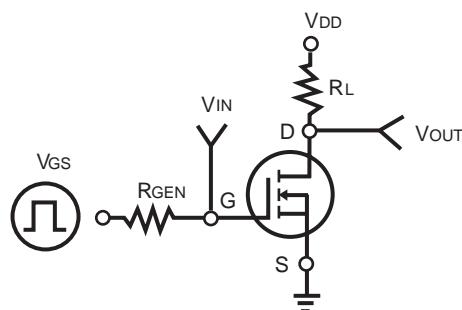


Figure 11. Switching Test Circuit

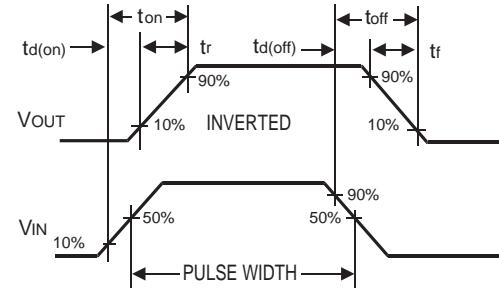


Figure 12. Switching Waveforms

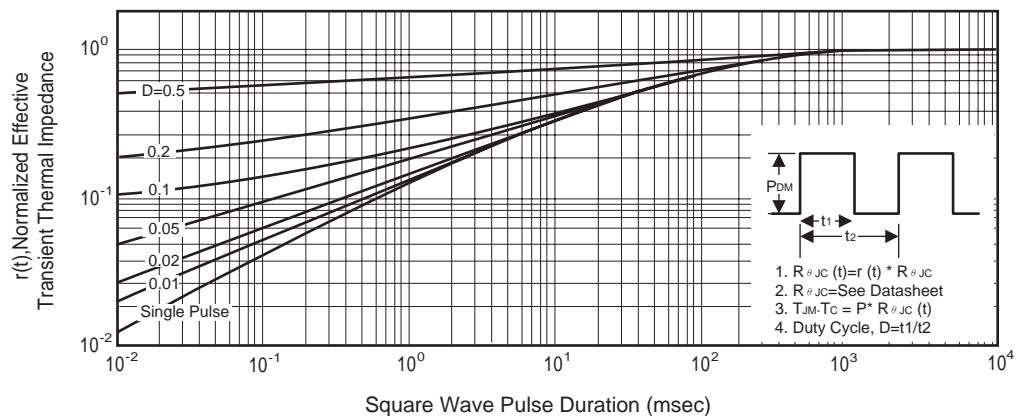


Figure 13. Normalized Thermal Transient Impedance Curve